

# **Product Change Notification - KSRA-24HJEE206**

Date:

30 Jun 2020

**Product Category:** 

Simple and Complex Programmable Logic

**Affected CPNs:** 



#### **Notification subject:**

CCB 4254 Initial Notice: Qualification of GTK as a new assembly site for selected Atmel products available in 24L SPDIP (.300in) package.

#### **Notification text:**

**PCN Status:** 

Initial notification

**PCN Type:** 

Manufacturing Change

#### **Microchip Parts Affected:**

Please open one of the icons found in the Affected CPNs section above.

NOTE: For your convenience Microchip includes identical files in two formats (.pdf and .xls).

#### **Description of Change:**

Qualification of GTK as a new assembly site for selected Atmel products available in 24L SPDIP (.300in) package.

# **Pre Change:**

Assembled at LPI using CRM-1033BF die attach, and G600 molding compound material

#### **Post Change:**

Assembled at LPI using EN-4900GC die attach, and G631M molding compound material

Pre and Post Change Summary:

Fre and Fost Cha	,	Pre Change	Post Change				
Assemi	oly Site	Lingsen Precision Industries, LTD. (LPI)	Greatek Electronic Inc. (GTK)				
Wire m	aterial	Au	Au				
Die attach material		CRM-1033BF	EN-4900GC				
Molding comp	ound material	G600	G631M				
Lead frame material		A194	A194				
	Tube Color	Clear	Clear				
Doolsing Modice	Plug Color	Green/White	Blue/White				
Packing Media:	Tube						
Tube	Dimensions	Minor dimensional changes. See pre and post change comparison					

#### **Impacts to Data Sheet:**

None

**Change Impact:** 

None

# **Reason for Change:**

To improve on-time delivery performance by qualifying GTK as a new assembly site

### **Change Implementation Status:**

In Progress

#### **Estimated Qualification Completion Date:**

November 2020



Note: Please be advised the qualification completion times may be extended because of unforeseen business conditions however implementation will not occur until after qualification has completed and a final PCN has been issued. The final PCN will include the qualification report and estimated first ship date. Also note that after the estimated first ship date guided in the final PCN customers may receive pre and post change parts.

#### **Time Table Summary:**

	June 2020				_	November 2020					
Workweek	23	24	25	26	27	>	45	46	47	48	49
Initial PCN Issue Date				X							
Qual Report Availability											Х
Final PCN Issue Date											Х

#### Method to Identify Change:

Traceability code

#### **Qualification Plan:**

Please open the attachments included with this PCN labeled as PCN # Qual Plan.

#### **Revision History:**

June 30, 2020: Issued initial notification.

The change described in this PCN does not alter Microchip's current regulatory compliance regarding the material content of the applicable products.

#### Attachment(s):

PCN KSRA-24HJEE206 Packing Pre and Post Change.pdf PCN KSRA-24HJEE206 Qual Plan.pdf

Please contact your local <u>Microchip sales office</u> with questions or concerns regarding this notification.

#### **Terms and Conditions:**

If you wish to <u>receive Microchip PCNs via email</u> please register for our PCN email service at our <u>PCN home page</u> select register then fill in the required fields. You will find instructions about registering for Microchips PCN email service in the <u>PCN FAQ</u> section.

If you wish to <u>change your PCN profile</u>, <u>including opt out</u>, please go to the <u>PCN home page</u> select login and sign into your myMicrochip account. Select a profile option from the left navigation bar and make the applicable selections.

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Affected Catalog Part Numbers (CPN)

ATF750C-7PX

ATF750LVC-15PU

ATF750CL-15PU

ATF750C-10PU

ATF22V10C-7PX

ATF22V10C-10PU

ATF22LV10C-10PU

ATF22V10C-15PU

ATF22V10CQZ-20PU

ATF22LV10CQZ-30PU

Date: Monday, June 29, 2020

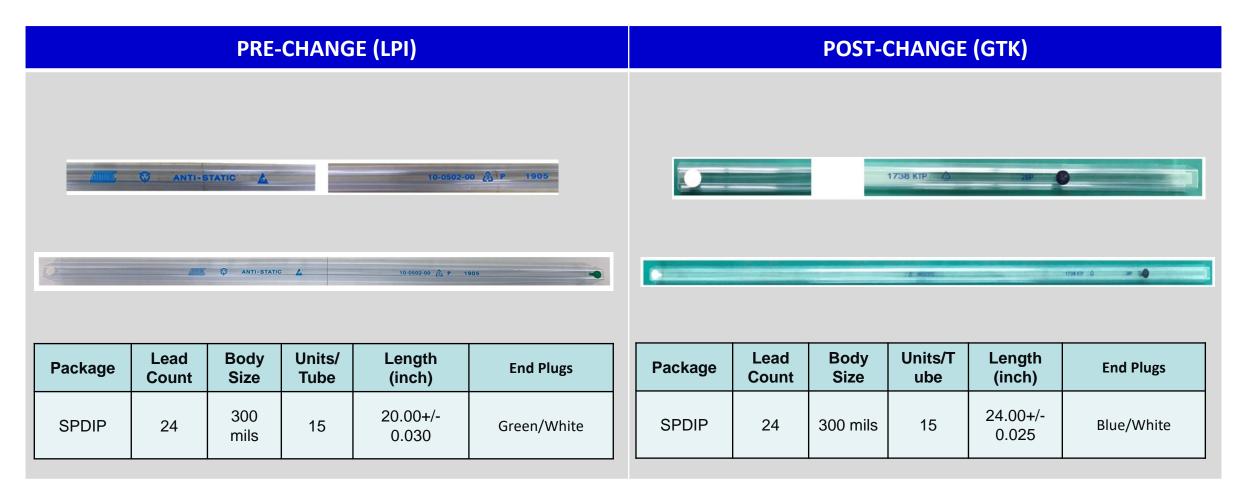
# CCB 4254 Pre and Post Change Summary PCN#: KSRA-24HJEE206



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# **Packing Information (Tube Comparison)**







# **QUALIFICATION PLAN SUMMARY**

PCN# KSRA-24HJEE206

Date: May 28, 2020

Qualification of GTK as a new assembly site for selected Atmel products available in 24L SPDIP (.300in) package.

Purpose: Qualification of GTK as a new assembly site for selected Atmel products available in 24L SPDIP (.300in) package.

in 24L SPDIP (.300in) package.								
	Assembly site	GTK						
	MP Code (MPC)	197117JDBC02						
Misc.	Part Number (CPN)	ATF750CL-15PU						
	MSL information	NA						
	Assembly Shipping Media (T/R, Tube/Tray)	Tube (GTK 41-01002-001)						
	Base Quantity Multiple (BQM)	15						
	Reliability Site	MPHIL						
	CCB No	4254						
	Paddle size	160 x160						
	Material	A194						
	DAP Surface Prep	Spot Plating						
	Treatment	None						
Lead-Frame	Process	Stamped						
Leau-Frame	Lead-lock	Yes						
	Part Number	11-0124K-002						
	Lead Plating	Matte Sn						
	Strip Size (mm)	10X1						
	Strip Density	10 ea/strip						
Bond Wire	Material	Au						
Die Attach	Part Number	EN-4900GC						
Die Attacii	Conductive	Yes						
MC	Part Number	G631M						
	PKG Type	SPDIP						
PKG	Pin/Ball Count	24						
	PKG width/size	300 mils						

Test Name	Conditions	Sample Size	Min. Qty of Spares per Lot (should be properly marked)	Qty of Lots	Total Units	Fail Accept Qty	Est. Dur. Days	ATE Test Site	REL Test Site	Special Instructions
Standard Pb-free Solderability	J-STD-002D; Perform 8 hour steam aging for Matte tin finish and 1 hour steam aging for NiPdAu finish prior to testing. Standard Pb-free: Matte tin/NiPdAu finish, SAC solder, wetting temp 245°C for both SMD & through hole packages.	22	5	1	27	> 95% lead coverage	5	MPHIL	MPHIL	Standard Pb-free solderability is the requirement. SnPb solderability (backward solderability- SMD reflow soldering) is required for any plating related changes and highly recommended for other package BOM changes.
Wire Bond Pull - WBP	Mil. Std. 883-2011	5	0	1	5	0 fails after TC	5	MPHIL	MPHIL	30 bonds from a min. 5 devices.
Wire Bond Shear - WBS	CDF-AEC-Q100-001	5	0	1	5		5	MPHIL	MPHIL	30 bonds from a min. 5 devices.
Physical Dimensions	Measure per JESD22 B100 and B108	10	0	3	30		5	MPHIL	MPHIL	
Lead Integrity	JESD22 B105	5	0	1	5	0 (No lead breakage or cracks)	5	MPHIL	MPHIL	10 leads from each of 5 parts. Not required for SMD, only required for through-hole.
External Visual	Mil. Std. 883-2009/2010	All devices prior to submission for qualification testing	0	3	ALL	0	5	MPHIL	MPHIL	
Preconditioning - Required for surface mount devices	+150°C Bake for 24 hours, moisture loading requirements per MSL level + 3X reflow at peak reflow temperature per Jedec-STD-020E for package type; Electrical test pre and post stress at +25°C.	231	15	3	738	0	15	MPHIL	MPHIL	Spares should be properly identified. 77 parts from each lot to be used for HAST, uHAST, Temp Cycle test.
HAST	+130°C/85% RH for 96 hours Electrical test pre and post stress at +25°C	77	5	3	246	0	10	MPHIL	MPHIL	Spares should be properly identified. Use the parts which have gone through Pre-conditioning.
UHAST	+130°C/85% RH for 96 hrs Electrical test pre and post stress at +25°C	77	5	3	246	0	10	MPHIL	MPHIL	Spares should be properly identified. Use the parts which have gone through Pre-conditioning.
Temp Cycle	-65°C to +150°C for 500 cycles. Electrical test pre and post stress at room temp; 3 gram force WBP, on 5 devices from 1 lot, test following Temp Cycle stress.	77	5	3	246	0	15	MPHIL	MPHIL	Spares should be properly identified. Use the parts which have gone through Pre-conditioning.